## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TRUTNA ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,839,335	01-2005	Sudo, Hiroaki	370/335
*	В	US-2001/0007574	07-2001	Liu et al.	375/219
*	С	US-7,187,715	03-2007	Balachandran et al.	375/242
*	D	US-2002/0021464	02-2002	Way, David G.	359/124
*	E	US-4,835,517	05-1989	van der Gracht et al.	375/222
*	F	US-2004/0246973	12-2004	Hoang et al.	370/395.21
*	G	US-2003/0151855	08-2003	Molstad et al.	360/316
	Н	US-			
		US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	α					
	R					_
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.